



Product Type : Network Camera

Applicant : VIVOTEK INC.

Address : 6F, No.192, Lien-Cheng Rd., Chung-Ho, New Taipei City, 235,

Taiwan, R.O.C.

Trade Name : VIVOTEK

Model Number : MD8562D

Test EN 55022: 2006+A1: 2007 / Class B

Specification EN 55024: 1998+A1: 2001+A2: 2003

: EN 61000-3-2: 2006 + A2: 2009 / Class A

EN 61000-3-3: 2008

AS/NZS CISPR 22: 2009

Issue Date : Sep. 22, 2011

Issue by

A Test Lab Techno Corp.

No. 140-1, Changan Street, Bade City, Taoyuan County 334, Taiwan R.O.C.

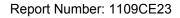
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Taiwan Accreditation Foundation accreditation number: 1330

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# **Revision History**

Rev.	Issue Date	Revisions	Revised By
00	Sep. 22, 2011	Initial Issue	

# **Verification of Compliance**

Issued Date: 2011/09/22

Product Type : Network Camera

Applicant : VIVOTEK INC.

Address : 6F, No.192, Lien-Cheng Rd., Chung-Ho, New Taipei City,

235, Taiwan, R.O.C.

Trade Name : VIVOTEK

Model Number : MD8562D

EUT Rated Voltage : DC 12V, 1.5A

Test Voltage : 230 Vac / 50 Hz

Applicable : EN 55022: 2006+A1: 2007 / Class B

Standard EN 55024: 1998+A1: 2001+A2: 2003

EN 61000-3-2: 2006 + A2: 2009 / Class A

EN 61000-3-3: 2008

AS/NZS CISPR 22: 2009

Test Result : Complied

Performing Lab. : A Test Lab Techno Corp.

No. 140-1, Changan Street, Bade City,

Taoyuan County 334, Taiwan R.O.C.

Tel: +886-3-2710188 / Fax: +886-3-2710190

Taiwan Accreditation Foundation accreditation number:

1330

http://www.atl-lab.com.tw/e-index.htm

The above equipment has been tested by A Test Lab Techno Corp., and found compliance with the requirements set forth in the Electromagnetic Compatibility Directive 2004/108/EC and technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Approved By

(Manager)

(Miller Lee )

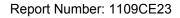
Reviewed By

(Testing Engineer) (Gary W



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# 1 General Information

# 1.1 Summary of Test Result

Emission						
Standard	ltem	Result	Remark			
EN 55022: 2006+A1: 2007 AS/NZS CISPR 22: 2009	Conducted and Radiated Emission	PASS	Meet Class B limit			
EN 61000-3-2: 2006 + A2: 2009	Harmonic current emissions	PASS	Meet Class A limit			
EN 61000-3-3: 2008	Voltage fluctuations & flicker	PASS	Meets the requirements			

Immunity						
Standard	Standard Item Result		Remark			
IEC 61000-4-2: 2008	ESD	PASS	Meets the requirements of Criterion B			
IEC 61000-4-3: 2008	RS	PASS	Meets the requirements of Criterion A			
IEC 61000-4-4: 2004	EFT	PASS	Meets the requirements of Criterion B			
IEC 61000-4-5: 2005	Surge	PASS	Meets the requirements of Criterion B			
IEC 61000-4-6: 2008	CS	PASS	Meets the requirements of Criterion A			
IEC 61000-4-8: 2009	PMF	PASS	Meets the requirements of Criterion A			
IEC 61000-4-11: 2004	Voltage dips & voltage variations	PASS	Meets the requirements of  Voltage Dips: 1) >95% reduction Criterion B 2) 30% reduction Criterion C  Voltage Interruptions: 1) >95% reduction Criterion C			

The test results of this report relate only to the tested sample(s) identified in this report. Manufacturer or whom it may concern should recognize the pass or fail of the test result.





# 1.2 Measurement Uncertainty

#### Conducted Emission

The measurement uncertainty is evaluated as ± 2.26 dB.

#### Conducted Emissions (Telecommunication Ports)

The measurement uncertainty is evaluated as ± 2.26 dB.

#### Radiated Emission

The measurement uncertainty is evaluated as  $\pm$  3.19 dB.

#### Harmonic Current Emission

The measurement uncertainty is evaluated as ± 1.2 %.

#### Voltage Fluctuations and Flicker

The measurement uncertainty is evaluated as  $\pm$  1.5 %.

#### Electrostatic Discharge

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 2005[E], the requirements for measurement uncertainty in ESD testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant ESD standards. The immunity test signal from the ESD system meet the required specifications in IEC 61000-4-2 through the calibration report with the calibrated uncertainty for the waveform of voltage and timing as being 1.52 % and 2.69%.

#### Radiated susceptibility

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 2005[E], the requirements for measurement uncertainty in RS testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant RS standards. The immunity test signal from the RS system meet the required specifications in IEC 61000-4-3 through the calibration for the uniform field strength and monitoring for the test level with the uncertainty evaluation report for the electrical filed strength as being 2.65 dB.

### Electrical fast transient/burst

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in EFT/Burst testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant FT/Burst standards. The immunity test signal from the FT/Burst system meet the required specifications in IEC 61000-4-4 through the calibration report with the calibrated uncertainty for the waveform of voltage. Frequency and timing as being 1.57% and 2.73%.



#### Surge

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 2005[E], the requirements for measurement uncertainty in Surge testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant Surge standards. The immunity test signal from the Surge system meet the required specifications in IEC 61000-4-5 through the calibration report with the calibrated uncertainty for the waveform of voltage and timing as being 1.58 % and 2.71%.

#### Conducted susceptibility

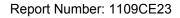
As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 2005[E], the requirements for measurement uncertainty in CS testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant CS standards. The immunity test signal from the CS system meet the required specifications in IEC 61000-4-6 through the calibration for unmodulated signal and monitoring for the test level with the uncertainty evaluation report for the injected modulated signal level through CDN and EM Clamp/Direct Injection as being 3.68 dB and 2.72 dB.

#### Power frequency magnetic field

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 2005[E], the requirements for measurement uncertainty in PFM testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant PFM standards. The immunity test signal from the PFM system meet the required specifications in IEC 61000-4-8 through the calibration report with the calibrated uncertainty for the Gauss Meter to verify the output level of magnetic field strength as being 1.8 %.

#### Voltage dips and interruption

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 2005[E], the requirements for measurement uncertainty in DIP testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant DIP standards. The immunity test signal from the DIP system meet the required specifications in IEC 61000-4-11 through the calibration report with the calibrated uncertainty for the waveform of voltage and timing as being 1.58 % and 2.72%.





# 2 **EUT Description**

Product :	Network Camera	
Trade Name :	VIVOTEK	
Model Number :	MD8562D	
Applicant :	VIVOTEK INC. 6F, No.192, Lien-Cheng Rd., Chung-Ho , New Taipei City, 235, Taiwan, R.O.C.	
Manufacturer :	VIVOTEK INC. 5F, No.168, Lien-Cheng Rd., Chung-Ho , New Taipei City, 235, Taiwan, R.O.C.	
	Component	
Power Adapter :	ENG, 3A-183WP12 I/P: 100-240VAC, 50-60Hz, 0.6A	
O/P: 12VDC, 1.5A Shielded, 1.7m, Non-Detachable at Power Adaptor		

# I/O Port Description :

I/O PORT TYPES		Q'TY	Test Description
1).	LAN Port	1	Connected to Notebook
2).	Audio in Port	1	Connected to Microphone
3).	Power Port	1	Connected to AC Adapter



# 3 Test Methodology

## 3.1. Decision of Test Mode

3.1.1 The following test mode(s) were scanned during the preliminary test:

Pre-Test Mode
Mode 1: Normal Operation

# 3.1.2 After the preliminary scan, the following test mode was found to produce the highest emission level

Final Test	Final Test Mode				
	Conducted Emission	Mode 1			
Emission	Radiated Emission	Mode 1			
LIIISSIOII	Harmonic current emissions	Mode 1			
	Voltage fluctuations & flicker	Mode 1			
	ESD	Mode 1			
	RS	Mode 1			
	EFT	Mode 1			
Immunity	Surge	Mode 1			
	CS	Mode 1			
	PMF	Mode 1			
	Voltage dips & voltage variations	Mode 1			

Then, the above highest emission mode of the configuration of the EUT and cable was chosen for all final test items.

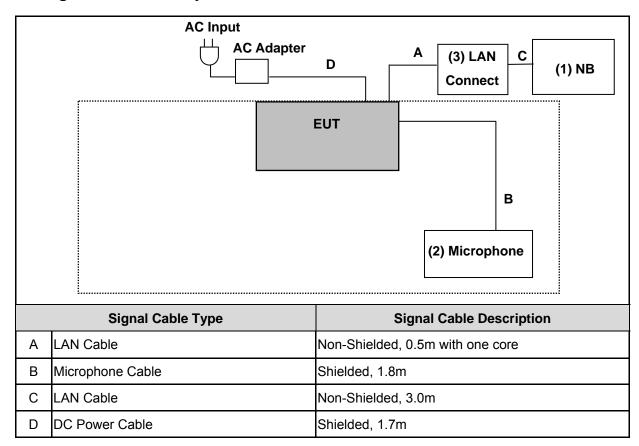
#### 3.2. EUT Exercise Software

1	Satur tha EUT	and cimulators	as shown on 3.3

- 2. Turn on the power of all equipment.
- 3. The EUT will start to operate and display the video figure from the signal source.
- 4. The EUT will display "video figure" on monitor.
- 5. Repeat the above procedure (3) to (4).



# 3.3. Configuration of Test System Details



	Devices Description							
	Product Manufacturer Model Number Serial Number Power Cord							
(1)	Notebook	DELL	D531	CN-OXM006-48643-87 A-3398	Non-Shielded, 2.0m			
(2)	Microphone	N/A	N/A	N/A	N/A			
(3)	LAN Connect	N/A	N/A	N/A	N/A			



# 3.4. Test Site Environment

Items	Test Item	Required (IEC 68-1)	Actual
Temperature (°C)		15-35	25.0
Humidity (%RH)	EN 55022 CE	25-60	55.0
Barometric pressure (mbar)		860-1060	950
Temperature (°C)		15-35	20.0
Humidity (%RH)	EN 55022 RE	25-60	40.0
Barometric pressure (mbar)		860-1060	950
Temperature (°C)			26.0
Humidity (%RH)	EN 61000-3-2		51.0
Barometric pressure (mbar)			950
Temperature (°C)			24.0
Humidity (%RH)	EN 61000-3-3		50.0
Barometric pressure (mbar)			950
Temperature (°C)		15-35	23.5
Humidity (%RH)	IEC 61000-4-2	30-60	44.5
Barometric pressure (mbar)		860-1060	950
Temperature (°C)	IEC 61000-4-3		24.2
Humidity (%RH)			54.5
Barometric pressure (mbar)			950
Temperature (°C)	IEC 61000-4-4	15-35	24.2
Humidity (%RH)		30-60	54.5
Barometric pressure (mbar)		860-1060	950
Temperature (°C)		15-35	24.2
Humidity (%RH)	IEC 61000-4-5	10-75	54.5
Barometric pressure (mbar)		860-1060	950
Temperature (°C)			24.6
Humidity (%RH)	IEC 61000-4-6		44.9
Barometric pressure (mbar)			950
Temperature (°C)		15-35	24.2
Humidity (%RH)	IEC 61000-4-8	25-75	54.5
Barometric pressure (mbar)		860-1060	950
Temperature (°C)		15-35	24.2
Humidity (%RH)	IEC 61000-4-11	25-75	54.5
Barometric pressure (mbar)		860-1060	950

# 4 Emission Test

## 4.1. Conducted Emission Measurement

## 4.1.1. Limit

#### 4.1.1.1. A.C. Mains Conducted Interference Limit:

Frequency	Class A	(dBuV)	Class B (dBuV)	
(MHz)	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	79	66	66 - 56	56 - 46
0.50 - 5.0	73	60	56	46
5.0 - 30.0	73	60	60	50

Note: (1) The lower limit shall apply at the transition frequencies.

#### 4.1.1.2. Telecommunication Port Conducted Interference Limits:

		Class A E	quipment		Class B Equipment				
Requirement (MHz)		e Limit μV)	Current Limit (dBµA) QP Avg.						ent Limit BµA)
	QP	Avg.			QP	Avg.	QP	Avg.	
0.15 to 0.50	97 to 87	84 to 74	53 to 43	53 to 43 40 to 30 8		74 to 64	40 to 30	30 to 20	
0.50 to 30	87	74	43	30	74	64	30	20	

## 4.1.2. Test Instruments

Describe	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
Test Receiver	R&S	ESCI	100367	06/30/2011	(1)
LISN	R&S	ENV216	101040	03/04/2011	(1)
LISN	R&S	ENV216	101041	03/04/2011	(1)
T-LISN	FCC	FCC-TLISN-T2-02	20574	05/13/2011	(1)
T-LISN	FCC	FCC-TLISN-T4-02	20529	04/19/2011	(1)
T-LISN	FCC	FCC-TLISN-T8-02	20576	05/13/2011	(1)
Test Site	ATL	TE02	TE02	N.C.R.	

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

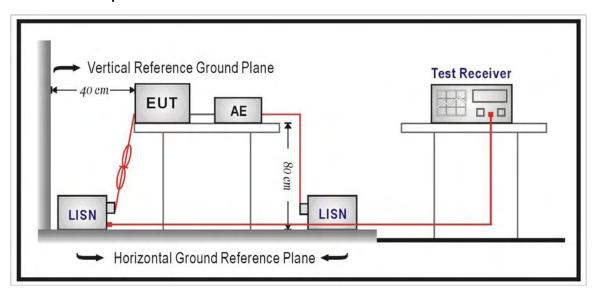
NOTE: N.C.R. = No Calibration Request.

<sup>(2)</sup> The limit decreases in line with the logarithm of the frequency in the range 0.15 to 0.50 MHz.

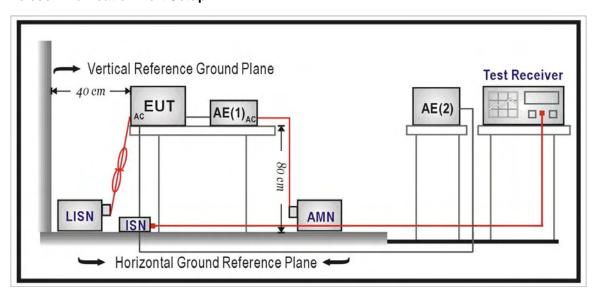


# 4.1.3. Test Setup

#### A.C. Mains Setup



## **Telecommunication Port Setup**





#### 4.1.4. Test Procedure

The EUT and simulators are connected to the main power through a line impedance stabilization network (L.I.S.N.). This provides a 50 ohm /50uH coupling impedance for the measuring equipment. The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination.

The mains voltage shall be supplied to the EUT via the LISN when the measurement of telecommunication port is performed. The common mode disturbances at the telecommunication port shall be connected to the ISN.

For A.C. mains conducted interference, measured both sides of A.C. lines and carried out using quasi-peak and average detector receivers of maximum conducted interference.

For telecommunication port interference measurement, using ISNs with suitable longitudinal conversion losses (LCL) as defined in the port of specification from manufacture, and the LCL shall be meet the related standard requirement. Measured the line and carried out using quasi-peak and average detector receivers of maximum conducted interference.

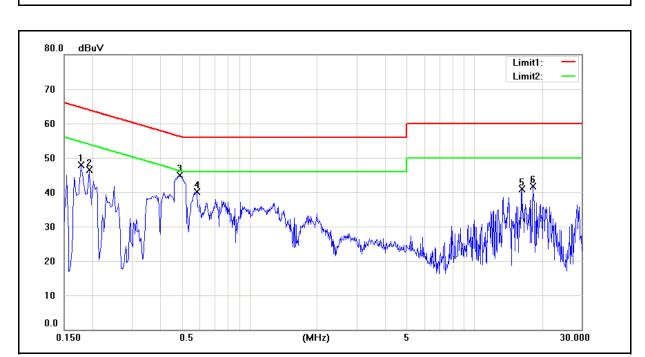
Conducted emissions were invested over the frequency range from 0.15 MHz to 30 MHz using a receiver bandwidth of 9 kHz. The equipment under test (EUT) shall be meet the limits in section 4.1.2, as applicable, including the average limit and the quasi-peak limit when using respectively (A.C. mains and telecommunication port), an average detector and quasi-peak detector measured in accordance with the methods described of related standard. Either the voltage limits or the current limits shall be met. If the average limit is met when using a quasi-peak detector receiver, the EUT shall be deemed to meet both limits and measurement with the average detector receiver is unnecessary.

If the reading of the measuring receiver shows fluctuations close to the limit, the reading shall be observed for at least 15 s at each measurement frequency; the higher reading shall be recorded with the exception of any brief isolated high reading which shall be ignored.

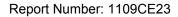


## 4.1.5. Test Result

Standard: EN 55022 Class B Line: L1 Test item: **Conducted Emission** Power: AC 230V/50Hz MD8562D Model: Temp.(°C)/Hum.(%RH): 26(°C)/60%RH Mode: Mode 1 Date: 2011/09/01 Test By: **Gary Wu** Description:



No.	Frequency	QP	AVG	Correction	QP	AVG	QP	AVG	QP	AVG	Remark
		reading	reading	factor	result	result	limit	limit	margin	margin	
	(MHz)	(dBuV)	(dBuV)	(dB)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	(dB)	(dB)	
1	0.1780	33.73	22.26	10.06	43.79	32.32	64.58	54.58	-20.79	-22.26	Pass
2	0.1940	31.50	18.67	10.05	41.55	28.72	63.86	53.86	-22.31	-25.14	Pass
3	0.4900	33.52	22.13	9.93	43.45	32.06	56.17	46.17	-12.72	-14.11	Pass
4	0.5860	28.55	15.19	9.89	38.44	25.08	56.00	46.00	-17.56	-20.92	Pass
5	16.2260	28.68	24.95	10.19	38.87	35.14	60.00	50.00	-21.13	-14.86	Pass
6	18.2420	29.49	25.16	10.35	39.84	35.51	60.00	50.00	-20.16	-14.49	Pass





Standard: EN 55022 Class B Line: Ν

Mode 1

Test item: **Conducted Emission** Power: AC 230V/50Hz

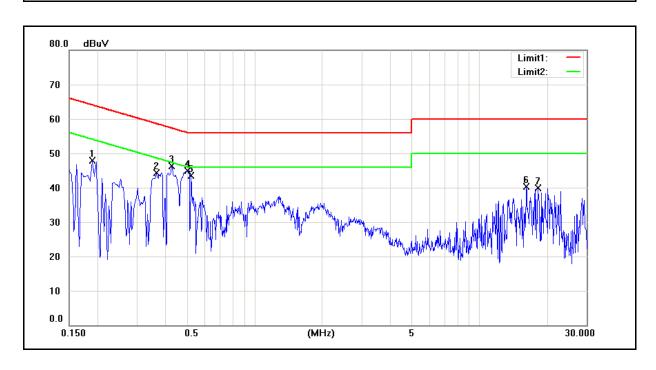
Model: MD8562D Temp.( $^{\circ}$ )/Hum.( $^{\circ}$ RH): 26(℃)/60%RH 2011/09/01

Date:

Test By: **Gary Wu** 

**Description:** 

Mode:



No.	Frequency	QP reading	AVG reading	Correction factor	QP result	AVG	QP limit	AVG limit	QP	AVG	Remark
	(MHz)	(dBuV)	(dBuV)	(dB)	(dBuV)	result (dBuV)	(dBuV)	(dBuV)	margin (dB)	margin (dB)	
1	0.1900	34.48	25.74	10.14	44.62	35.88	64.04	54.04	-19.42	-18.16	Pass
2	0.3660	32.30	22.20	10.06	42.36	32.26	58.59	48.59	-16.23	-16.33	Pass
3	0.4300	33.69	22.42	10.04	43.73	32.46	57.25	47.25	-13.52	-14.79	Pass
4	0.5020	33.14	20.99	10.01	43.15	31.00	56.00	46.00	-12.85	-15.00	Pass
5	0.5220	31.55	15.81	10.00	41.55	25.81	56.00	46.00	-14.45	-20.19	Pass
6	16.1660	27.99	24.29	10.24	38.23	34.53	60.00	50.00	-21.77	-15.47	Pass
7	18.2420	29.41	25.11	10.39	39.80	35.50	60.00	50.00	-20.20	-14.50	Pass



Standard: ISN(Voltage)-Class B N/A Line:

MD8562D

Test item: **Conducted Emission** Power: AC 230V/50Hz 26(℃)/60%RH

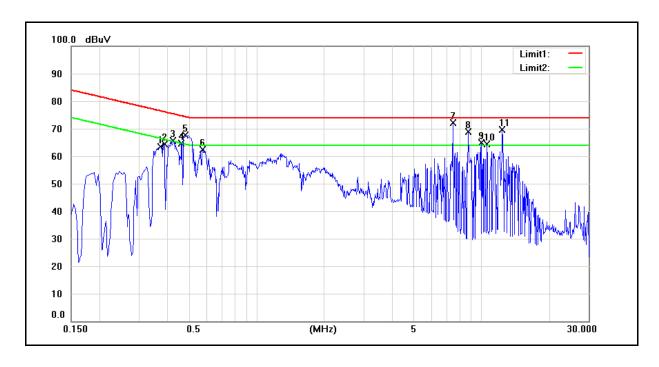
Mode: ISN 10M Date: 2011/09/01

> Test By: **Gary Wu**

Temp.( $^{\circ}$ )/Hum.( $^{\circ}$ RH):

**Description:** 

Model:



No.	Frequency		AVG	Correction		AVG	QP	AVG	QP	AVG	Remark
	(MHz)	reading (dBuV)	reading (dBuV)	factor (dB)	result (dBuV)	result (dBuV)	limit (dBuV)	limit (dBuV)	margin (dB)	margin (dB)	
1	0.3740	51.91	40.30	10.46	62.37	50.76	76.41	66.41	-14.04	-15.65	Pass
2	0.3900	51.49	34.66	10.44	61.93	45.10	76.06	66.06	-14.13	-20.96	Pass
3	0.4260	55.61	44.13	10.43	66.04	54.56	75.33	65.33	-9.29	-10.77	Pass
4	0.4660	52.71	35.56	10.40	63.11	45.96	74.58	64.58	-11.47	-18.62	Pass
5	0.4860	56.28	43.59	10.40	66.68	53.99	74.24	64.24	-7.56	-10.25	Pass
6	0.5780	51.38	37.82	10.36	61.74	48.18	74.00	64.00	-12.26	-15.82	Pass
7	7.5000	59.63	41.05	10.23	69.86	51.28	74.00	64.00	-4.14	-12.72	Pass
8	8.7500	55.03	34.16	10.35	65.38	44.51	74.00	64.00	-8.62	-19.49	Pass
9	10.0540	46.99	26.93	10.52	57.51	37.45	74.00	64.00	-16.49	-26.55	Pass
10	10.5980	50.59	32.46	10.57	61.16	43.03	74.00	64.00	-12.84	-20.97	Pass
11	12.4460	52.31	33.41	10.62	62.93	44.03	74.00	64.00	-11.07	-19.97	Pass



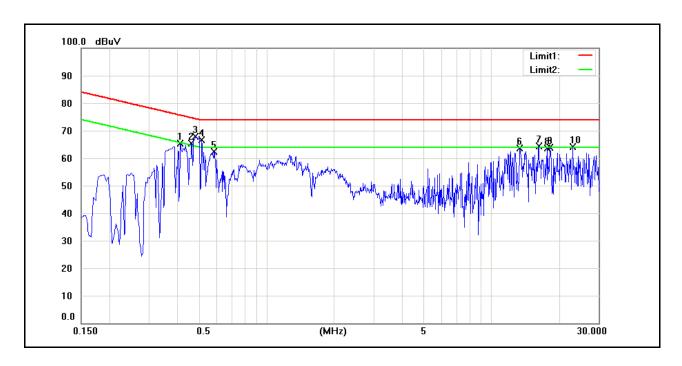
Standard: ISN(Voltage)-Class B Line: N/A

Test item: Conducted Emission Power: AC 230V/50Hz Model: MD8562D Temp.( $^{\circ}$ )/Hum.( $^{\circ}$ RH): 26( $^{\circ}$ )/60%RH

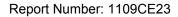
Mode: ISN 100M Date: 2011/09/01

Test By: Gary Wu

Description:



No.	Frequency	QP	AVG	Correction	QP	AVG	QP	AVG	QP	AVG	Remark
		reading	reading	factor	result	result	limit	limit	margin	margin	
	(MHz)	(dBuV)	(dBuV)	(dB)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	(dB)	(dB)	
1	0.4140	52.85	40.72	10.44	63.29	51.16	75.57	65.57	-12.28	-14.41	Pass
2	0.4660	53.27	36.27	10.40	63.67	46.67	74.58	64.58	-10.91	-17.91	Pass
3	0.4860	56.60	43.98	10.40	67.00	54.38	74.24	64.24	-7.24	-9.86	Pass
4	0.5140	55.38	41.15	10.38	65.76	51.53	74.00	64.00	-8.24	-12.47	Pass
5	0.5860	50.67	36.83	10.35	61.02	47.18	74.00	64.00	-12.98	-16.82	Pass
6	13.3580	52.38	49.23	10.56	62.94	59.79	74.00	64.00	-11.06	-4.21	Pass
7	16.2300	52.94	50.54	10.44	63.38	60.98	74.00	64.00	-10.62	-3.02	Pass
8	17.6940	52.61	49.87	10.52	63.13	60.39	74.00	64.00	-10.87	-3.61	Pass
9	18.2420	52.69	50.12	10.57	63.26	60.69	74.00	64.00	-10.74	-3.31	Pass
10	23.1300	52.49	50.18	10.77	63.26	60.95	74.00	64.00	-10.74	-3.05	Pass



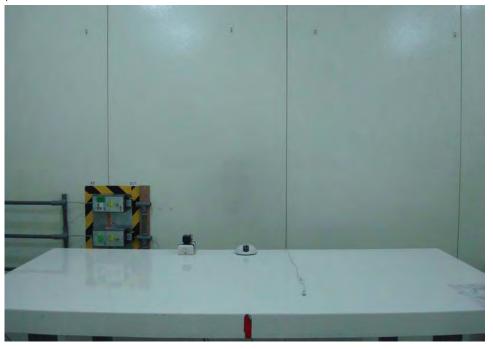


# 4.1.6. Test Photograph

A.C. Mains:

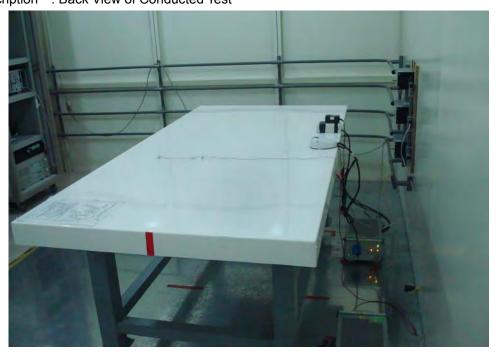
Test Mode : Mode 1

Description : Front View of Conducted Test



Test Mode : Mode 1

Description : Back View of Conducted Test



#### 4.2. Radiated Interference Measurement

# 4.2.1. Limit

Frequency (MHz)	dBuV/m (Di	stance 10m)
(MHz)	Class A	Class B
30 ~ 230	40	30
230 ~ 1000	47	37

NOTE: The lower limit shall apply at the transition frequencies.

_		dBuV/m (Distance 3m)						
Frequency (MHz)	Clas	ss A	Class B					
,	Average	Peak	Average	Peak				
1000 ~ 3000	56	76	50	70				
3000 ~ 6000	60	80	54	74				

NOTE: The lower limit shall apply at the transition frequencies.

## 4.2.2. Test Instruments

		10 Meter Chamb	per		
Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
Pre Amplifier	Agilent	8447D	2944A11120	01/11/2011	(1)
Pre Amplifier	Agilent	8447D	2944A11119	01/11/2011	(1)
Test Receiver	R&S	ESCI	100722	10/14/2010	(1)
Test Receiver	R&S	ESCI	101000	12/15/2010	(1)
Broadband Antenna	SCHWARZBECK MESS-ELEKTRONIK	VULB 9160	9160-3268	07/01/2011	(1)
Broadband Antenna	SCHWARZBECK MESS-ELEKTRONIK	VULB 9160	9160-3273	12/30/2010	(1)
Horn Antenna (1~18GHz)	SCHWARZBECK MESS-ELEKTRONIK	BBHA9120D	9120D-550	06/29/2011	(1)
Horn Antenna (18~40GHz)	SCHWARZBECK MESS-ELEKTRONIK	BBHA9170	9170-320	06/28/2011	(1)
Test Site	ATL	TE06	TE06	09/05/2011	(1)

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

NOTE: N.C.R. = No Calibration Request.

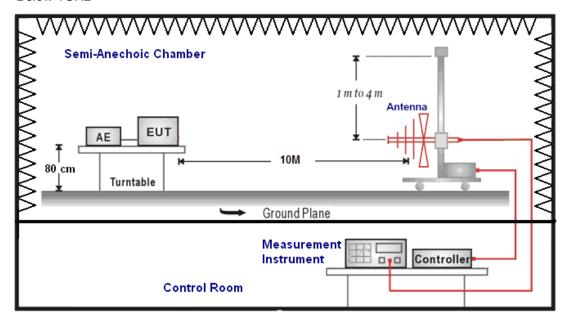
		3 Meter Char	mber		
Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
RF Pre-selector	Agilent	N9039A	MY46520256	01/18/2011	(2)
Spectrum Analyzer	Agilent	E4446A	MY46180578	01/18/2011	(1)
Pre Amplifier	Agilent	8449B	3008A02237	02/23/2011	(1)
Pre Amplifier	Agilent	8447D	2944A10961	02/23/2011	(1)
Broadband Antenna (30MHz~1GHz)	SCHWARZBECK MESS-ELEKTRO NIK	VULB9163	9163-270	07/29/2011	(1)
Horn Antenna (1~18GHz)	SCHWARZBECK MESS-ELEKTRO NIK	BBHA9120D	9120D-550	06/29/2011	(1)
Horn Antenna (18~40GHz)	SCHWARZBECK MESS-ELEKTRO NIK	BBHA9170	9170-320	06/28/2011	(1)
Test Site	ATL	TE01	888001	12/24/2010	(1)

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

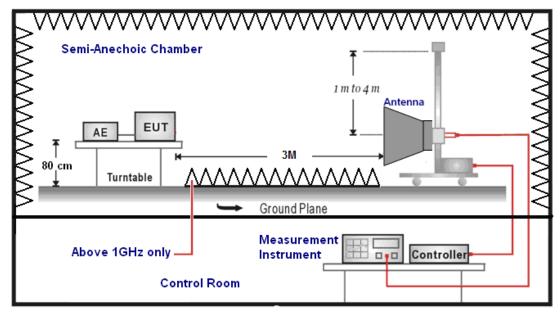
NOTE: N.C.R. = No Calibration Request.

# 4.2.3. Setup

Below 1GHz



Above 1GHz



#### 4.2.4. Test Procedure

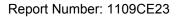
The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. When the EUT is floor- standing equipment, it is placed on the ground plane which has a 15 cm non-conductive covering to insulate the EUT from the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT was positioned such that the distance from antenna to the EUT was 10 meters for under 1GHz, and 3 meter for above 1GHz if the highest internal source frequency of the EUT is higher than 108 MHz.

The highest internal source of a EUT is defined as the highest frequency generated or used within the EUT or on which the EUT operates or tunes. If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz. If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz. If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, the measurement shall only be made up to 5 GHz. If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less.

The antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level. Both horizontal and vertical polarization of the antenna are set on measurement. In order to find the maximum emission, all of the interface cables must be manipulated on radiated measurement.

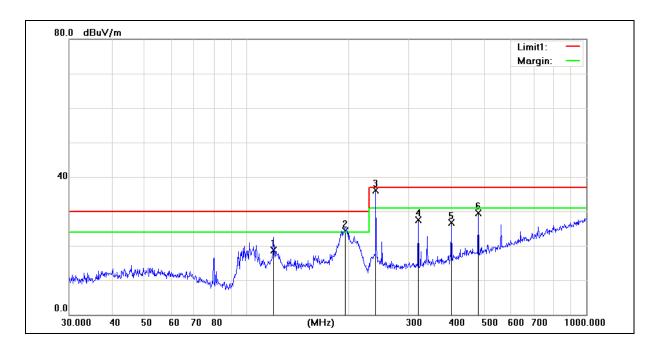
Radiated emissions were invested over the frequency range from 30MHz to1GHz using a receiver bandwidth of 120 kHz. Radiated was performed at an antenna to EUT distance of 10 meters.



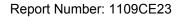


## 4.2.5. Test Result

Standard: EN 55022 Class B **Test Distance:** 10m Test item: **Radiated Emission** AC 230V/50Hz Power: Model: MD8562D Temp.(°C)/Hum.(%RH): 26(°C)/60%RH 2011/09/13 Mode: Mode 1 Date: Ant.Polar.: Horizontal **Gary Wu** Test By:



No.	Frequency	Reading	Correct	Result	Limit	Margin	Height	Degree	Remark
	(MHz)	(dBuV)	Factor(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(cm)	(°)	
1	119.8556	32.88	-14.18	18.70	30.00	-11.30	300	113	QP
2	195.1365	39.44	-15.14	24.30	30.00	-5.70	400	99	QP
3	239.9873	49.39	-13.19	36.20	37.00	-0.80	400	85	QP
4	319.9370	38.19	-10.69	27.50	37.00	-9.50	300	82	QP
5	400.4320	35.80	-9.00	26.80	37.00	-10.20	300	249	QP
6	480.5276	36.83	-7.33	29.50	37.00	-7.50	300	278	QP

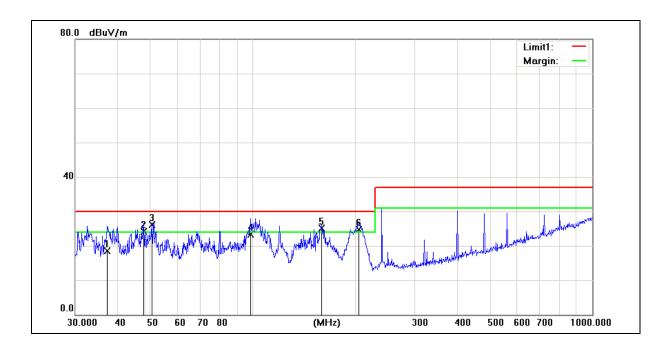




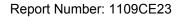
Standard: EN 55022 Class B Test Distance: 10m

Test item: Radiated Emission Power: AC 230V/50Hz Model: MD8562D Temp.( $^{\circ}$ C)/Hum.( $^{\circ}$ RH): 26( $^{\circ}$ C)/60%RH

Mode: Mode 1 Date: 2011/09/13
Ant.Polar.: Vertical Test By: Gary Wu



No.	Frequency	Reading	Correct	Result	Limit	Margin	Height	Degree	Remark
	(MHz)	(dBuV)	Factor(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(cm)	(°)	
1	37.2854	33.82	-15.32	18.50	30.00	-11.50	100	239	QP
2	47.6584	38.58	-14.38	24.20	30.00	-5.80	100	192	QP
3	50.4090	40.38	-14.28	26.10	30.00	-3.90	100	168	QP
4	98.4865	40.48	-17.18	23.30	30.00	-6.70	100	299	QP
5	159.7844	37.43	-12.23	25.20	30.00	-4.80	100	160	QP
6	205.6750	40.25	-15.45	24.80	30.00	-5.20	100	259	QP



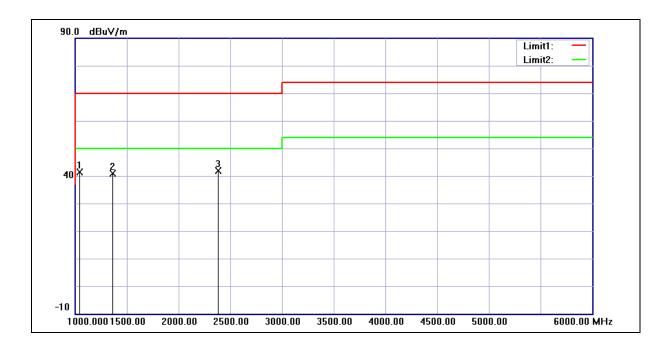


Standard: EN 55022 Class B Test Distance: 3m

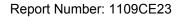
Test item: Radiated Emission Power: AC 230V/50Hz Model: MD8562D Temp.( $^{\circ}$ )/Hum.( $^{\circ}$ RH): 26( $^{\circ}$ )/60%RH

Mode: Mode 1 (1GHz~6GHz) Date: 2011/09/02

Ant.Polar.: Horizontal Test By: Gary Wu



No.	Frequency	Reading	Correct	Result	Limit	Margin	Remark
	(MHz)	(dBuV)	Factor(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	
1	1040.000	47.49	-6.14	41.35	70.00	-28.65	peak
2	1360.000	45.21	-4.34	40.87	70.00	-29.13	peak
3	2380.000	42.26	-0.26	42.00	70.00	-28.00	peak



2011/09/02



Mode:

Standard: EN 55022 Class B Test Distance: 3m

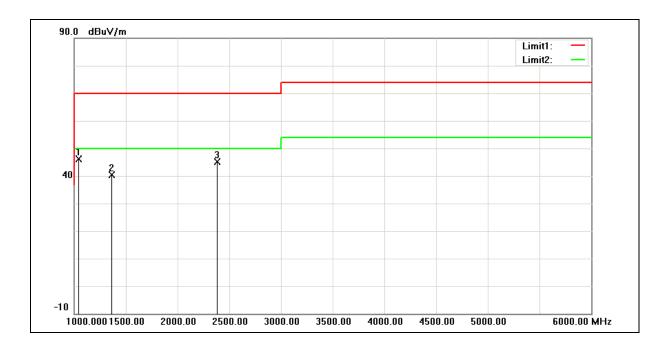
Mode 1 (1GHz~6GHz)

Test item: Radiated Emission Power: AC 230V/50Hz

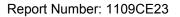
Model: MD8562D Temp.( $^{\circ}$ )/Hum.( $^{\circ}$ RH): 26( $^{\circ}$ )/60%RH

Date:

Ant.Polar.: Vertical Test By: Gary Wu



No.	Frequency	Reading	Correct	Result	Limit	Margin	Remark
	(MHz)	(dBuV)	Factor(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	
1	1040.000	52.31	-6.14	46.17	70.00	-23.83	peak
2	1360.000	44.83	-4.34	40.49	70.00	-29.51	peak
3	2380.000	45.29	-0.26	45.03	70.00	-24.97	peak

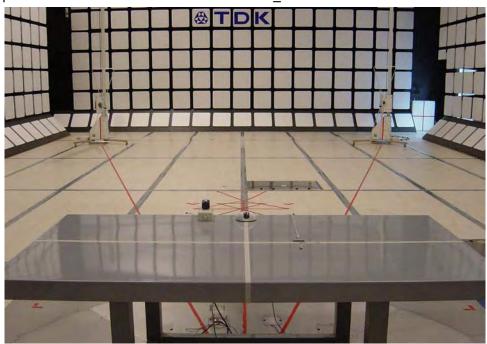




# 4.2.6. Test Photograph

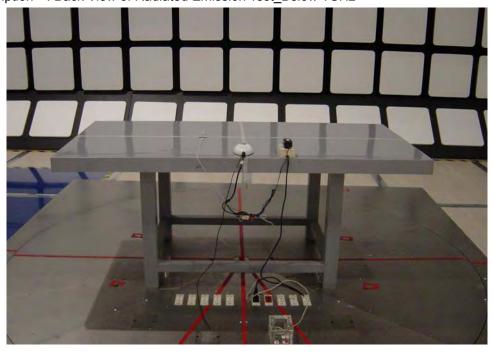
Test Mode : Mode 1

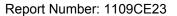
Description : Front View of Radiated Emission Test\_Below 1GHz



Test Mode : Mode 1

Description : Back View of Radiated Emission Test Below 1GHz





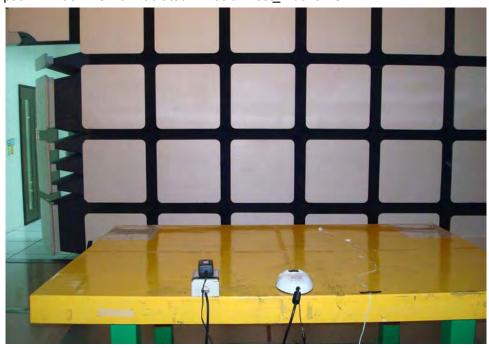
Test Mode : Mode 1

Description : Front View of Radiated Emission Test\_Above 1GHz



Test Mode : Mode 1

Description : Back View of Radiated Emission Test\_Above 1GHz





## 4.3. Harmonics Current Measurement

## 4.3.1. Limit

#### **Limits of Class A Harmonics Currents**

Harmonics Order	Maximum Permissible harmonic current	Harmonics Order	Maximum Permissible harmonic current
n	(A)	n	(A)
Odd I	harmonics	Even h	armonics
3	2.30	2	1.08
5	1.14	4	0.43
7	0.77	6	0.30
9	0.40	$8 \le n \le 40$	0.23 * 8/n
11	0.33		
13	0.21		
15 ≤ n ≤ 39	0.15 * 15/n		

#### **Limits of Class B Harmonics Currents**

For Class B equipment, the harmonic of the input current shall not exceed the maximum permissible values given in table which is the limit of Class A multiplied by a factor of 1.5.

#### **Limits of Class C Harmonics Currents**

Harmonics Order	Maximum Permissible harmonic current Expressed as a percentage of the input current at the fundamental frequency					
n	(%)					
2	2					
3	30 · λ*					
5	10					
7	7					
9	5					
$11 \le n \le 39$ (odd harmonics only)	3					
	*λ is the circuit power factor					

## **Limits of Class D Harmonics Currents**

Harmonics Order	Maximum Permissible harmonic current per watt	Maximum Permissible harmonic current
n	(mA/W)	(A)
3	3.4	2.30
5	1.9	1.14
7	1.0	0.77
9	0.5	0.40
11	0.35	0.33
$11 \le n \le 39$ (odd harmonics only)	3.85/n	See limit of Class A



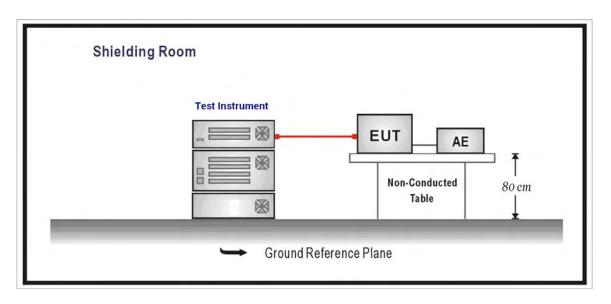
#### 4.3.2. Test Instrument

Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
Power Harmonics Analyzers	EMC-Partner AG	HAR1000-1P	171	02/07/2011	(2)
Test Site	ATL	TE05	TE05	N.C.R.	

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

NOTE: N.C.R. = No Calibration Request.

# 4.3.3. Setup



#### 4.3.4. Test Procedure

The EUT was placed on the top of a wooden table 0.8 meters above the ground and the EUT is supplied in series with power analyzer from a power source having the same normal voltage and frequency as the rated supply voltage and the equipment under test. And the rated voltage at the supply voltage of EUT of 0.94 times and 1.06 times shall be performed.

A definition of the normal load or of the conditions for adequate heat discharge can usually be found in the EN publication corresponding to the equipment under test.

Equipment may have several separately controlled circuits. Each circuit is considered as a single piece of equipment if it can be operated independently and separately from the other circuits.

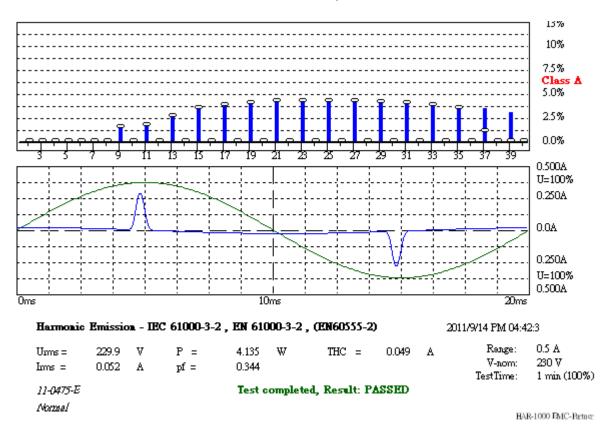
#### 4.3.5. Test Result

Product	Network Camera				
Test Item	Power Harmonics				
Test Mode	Mode 1				
Date of Test	2011/09/14	Test Site	TE05		

Test Result: Pass Source qualification: Normal

**Current & voltage waveforms** 

Harmonics and Class D limit line European Limits



### Note 1:

For the following categories of equipment limits are not specified in this edition of the standard.

- -Equipment with a rated power of 75 W or less, other than lighting equipment.
- -Professional equipment with a total rated power greater than 1 kW;
- -Symmetrically controlled heating elements with a rated power less than or equal to 200 W;
- -Independent dimmers for incandescent lamps with a rated power less than or equal to 1 kW.



Test result: Pass Worst harmonic was #0 with 0.00% of the limit.

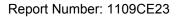
Urms = 229.9V 49.987 0.5 A Freq = Range: lpk = = = Irms = 0.052A 0.298A 5.706 cf = 4.135W 12.01VA = рf 0.344 = THDi = 89.5 % THDu = 0.10 % Class A

Test - Time : 1min (100 %)

Test completed, Result: PASSED

Order	Freq. [Hz]	lavg [A]	lavg%L [%]	lmax [A]	lmax%L [%]	Limit [A]	Status
1	50 100	0.0247	0.0000	0.0248 0.0003	0.0283	1.0800	Door
2 3 4		0.0000	0.0000				Pass
3 1	150 200	0.0155		0.0156	0.6780 0.0710	2.3000	Pass
		0.0000	0.0000 1.3497	0.0003	1.3572	0.4300 1.1400	Pass
5	250 300	0.0154		0.0155	0.1017		Pass
6 7		0.0000	0.0000	0.0003		0.3000	Pass
	350 400	0.0152	1.9676	0.0152	1.9777 0.1460	0.7700 0.2300	Pass
8		0.0000	0.0000	0.0003			Pass
9 10	450 500	0.0148 0.0000	3.7019 0.0000	0.0149 0.0003	3.7231 0.1824	0.4000 0.1840	Pass
							Pass
11 12	550	0.0144	4.3575	0.0145	4.3834	0.3300	Pass
13	600	0.0000	0.0000	0.0003	0.2189	0.1533	Pass
	650 700	0.0139	6.6056	0.0139	6.6412 0.2554	0.2100	Pass
14		0.0000	0.0000	0.0003		0.1314	Pass
15	750	0.0133	8.8566	0.0134	8.9111	0.1500	Pass
16	800	0.0000	0.0000	0.0004	0.3184	0.1150	Pass
17	850	0.0126	9.5515	0.0127	9.5920 0.3582	0.1324 0.1022	Pass
18	900	0.0000	0.0000	0.0004			Pass
19	950	0.0120	10.091	0.0120	10.128	0.1184	Pass
20	1000	0.0000	0.0000	0.0004	0.3981	0.0920	Pass
21	1050	0.0112	10.465	0.0113	10.510	0.1071	Pass
22	1100	0.0000	0.0000	0.0004	0.4743	0.0836	Pass
23	1150	0.0104	10.674	0.0105	10.731	0.0978	Pass
24	1200	0.0000	0.0000	0.0004	0.4777	0.0767	Pass
25	1250	0.0096	10.722	0.0097	10.783	0.0900	Pass
26	1300	0.0000	0.0000	0.0004	0.5175	0.0708	Pass
27	1350	0.0088	10.616	0.0089	10.657	0.0833	Pass
28	1400	0.0000	0.0000	0.0004	0.5573	0.0657	Pass
29	1450	0.0080	10.359	0.0081	10.384	0.0776	Pass
30	1500	0.0000	0.0000	0.0004	0.5971	0.0613	Pass
31	1550	0.0072	9.9827	0.0073	10.007	0.0726	Pass
32	1600	0.0000	0.0000	0.0003	0.5838	0.0575	Pass
33	1650	0.0065	9.4776	0.0065	9.5337	0.0682	Pass
34	1700	0.0000	0.0000	0.0003	0.6203	0.0541	Pass
35	1750	0.0057	8.8791	0.0057	8.9247	0.0643	Pass
36	1800	0.0000	0.0000	0.0003	0.5971	0.0511	Pass
37	1850	0.0017	2.7286	0.0050	8.2804	0.0608	Pass
38	1900	0.0000	0.0000	0.0003	0.6303	0.0484	Pass
39	1950	0.0000	0.0000	0.0043	7.5114	0.0577	Pass
40	2000	0.0000	0.0000	0.0003	0.5971	0.0460	Pass

- 1. Dynamic limits were applied for this test. The highest harmonics values in the above table may not occur at the same window as the maximum harmonics/limit ratio.
- 2. According to EN61000-3-2 paragraph 7 the note 1 and 2 are valid for all applications having an active input power >75W. Others the result should be pass.





# 4.3.6. Test Photograph

Test Mode : Mode 1

Description : Power Harmonics Test Setup



# 4.4. Voltage Fluctuation and Flicker

#### 4.4.1. Limit

The following limits apply:

- -- the value of P<sub>st</sub> shall not be greater than 1.0;
- -- the value of P<sub>lt</sub> shall not be greater than 0.65;
- -- the value of d(t) during a voltage change shall not exceed 3.3 % for more than 500 ms;
- -- the relative steady-state voltage change, d<sub>c</sub>, shall not exceed 3.3 %;
- -- the maximum relative voltage change, d<sub>max</sub>, shall not exceed;
  - a) 4 % without additional conditions;
  - b) 6 % for equipment which is:
    - -- switched manually, or
    - -- switched automatically more frequently than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds), or manual restart, after a power supply interruption.

Note: The cycling frequency will be further limited by the P<sub>st</sub> and P<sub>1t</sub> limit.

For example: a  $d_{max}$  of 6% producing a rectangular voltage change characteristic twice per hour will give a  $P_{1t}$  of about 0.65.

- c) 7 % for equipment which is:
  - -- attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as lawn mowers, portable tools such as electric drills), or
  - -- switched on automatically, or is intended to be switched on manually, no more than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.

P<sub>st</sub> and P<sub>1t</sub> requirements shall not be applied to voltage changes caused by manual switching.

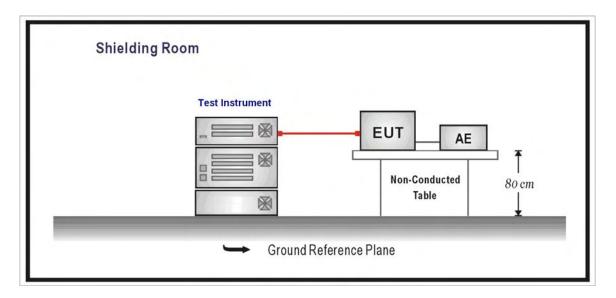
#### 4.4.2. Test Instrument

Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
Power Harmonics Analyzers	EMC-Partner AG	HAR1000-1P	171	02/07/2011	(2)
Test Site	ATL	TE05	TE05	N.C.R.	

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

NOTE: N.C.R. = No Calibration Request.

### 4.4.3. Setup



#### 4.4.4. Test Procedure

The EUT is supplied in series with power analyzer from a power source having the same normal voltage and frequency as the rated supply voltage and the equipment under test. And the rated voltage at the supply voltage of EUT of 0.94 times and 1.06 times shall be performed.

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.

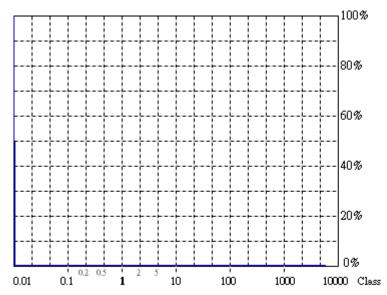
During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

#### 4.4.5. Test Result

Product	Network Camera		
Test Item	Flicker		
Test Mode	Mode 1		
Date of Test	2011/09/14	Test Site	TE05

Test Result: Pass Status: Test Completed

### Plt and limit line



 Actual Flicker (Fli):
 0.00

 Short-term Flicker (Pst):
 0.07

 Limit (Pst):
 1.00

 Long-term Flicker (Plt):
 0.07

Limit (Plt): 0.65

Maximum Relative

Volt. Change (dmax): 0.00% Limit (dmax): 4.00%

Relative Steady-state
Voltage Change (dc): 0.01%
Limit (dc): 3.30%

Maximum Interval exceeding 3.30% (dt): 0.00ms Limit (dt>Lim): 500ms

2011/9/14 PM 04:53:5

Flicker Emission - IEC 61000-3-3, EN 61000-3-3, (EN60555-3)

Umrs = 229.9 V P = 4.160 W Imrs = 0.050 A pf = 0.362 Range: 0.5 A V-nom: 230 V TestTime: 10 min (100%)

11-0475-E Test completed, Result: PASSED
Normal

HAR-1000 PMC-Partner

Urms = 229.9V Freq = 50.000 Range: 0.5 A Irms = 0.050A 0.268A lpk = cf 5.356 4.160W S 11.51VA pf 0.362

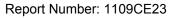
Test - Time: 1 x 10min = 10min (100 %)

LIN (Line Impedance Network): L: 0.24ohm +j0.15ohm N: 0.16ohm +j0.10ohm

Limits: Plt : 0.65 Pst : 1.00 dmax : 4.00 % dc : 3.30 %

dtLim: 3.30 % dt>Lim: 500ms

Test completed, Result: PASSED





# 4.4.6. Test Photograph

Test Mode : Mode 1

Description : Flicker Test Setup





# 5 Immunity Test

## 5.1. Electrostatic Discharge (ESD)

## 5.1.1. Test Specification

IEC 61000-4-2							
<b>Environmental Phenomena</b>	Units	Test Specification	Performance Criterion				
	Enclosure Port						
Electrostatic Discharge	kV (Charge Voltage)	±8 Air Discharge	D				
Electrostatic Discharge	kv (Charge Voltage)	±4 Contact Discharge	ם				

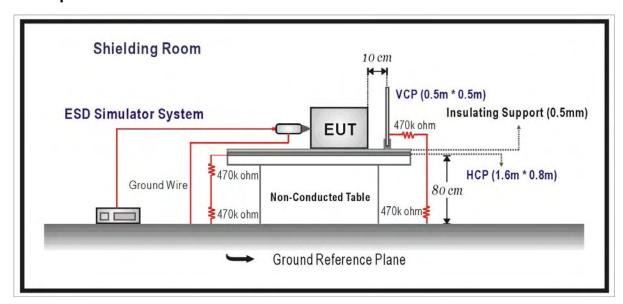
#### 5.1.2. Test Instrument

Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
Discharge Gun	Noiseken	ESS-2002	NOISE- ESS-2002CM	03/15/2011	(1)
0.8m Height Wooden Table	N/A	N/A	N/A	N.C.R.	
Test Site	ATL	TE04	TE04	N.C.R.	

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

NOTE: N.C.R. = No Calibration Request.

### 5.1.3. Setup



#### 5.1.4. Test Procedure

The discharges shall be applied in two ways:

- a) Contact discharges to the conductive surfaces and coupling planes:
  - The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the Horizontal Coupling Plane (HCP). The remaining three test points shall each receive at least 50 direct contact discharges. If no direct contact test point be available, then at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.
- b) Air discharges at slots and apertures and insulating surfaces: On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.

The basic test procedure was in accordance with IEC 61000-4-2:

- a) The EUT was located 0.1 m minimum from all side of the HCP (dimensions 1.6m x 0.8m).
- b) The support units were located another table 30 cm away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.
- c) The time interval between two successive single discharges was at least 1 second.
- d) Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- e) Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- f) At least ten single discharges (in the most sensitive polarity) were applied at the front edge of each HCP opposite the center point of each unit of the EUT and 0.1 meters from the front of the EUT. The long axis of the discharge electrode was in the plane of the HCP and perpendicular to its front edge during the discharge.
- g) At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane (VCP) in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

#### 5.1.5. Test Result

Product	Network Camera				
Test Item	Electrostatic Discharge				
Test Mode	Mode 1				
Date of Test	09/19/2011	Test Site	TE04		

_	Air Discharge											
Test	Test Levels									Res	ults	
Points	±2 kV		rmance erion	± 4 kV		rmance terion	±8 Performance KV Criterion		Pass	Fail	Observation	
Front	$\boxtimes$	⊠A	□В	$\boxtimes$	⊠A	□В	$\boxtimes$	⊠A	□в	$\boxtimes$		
Back		⊠A	□в	$\boxtimes$	⊠A	□в	$\boxtimes$	⊠A	□в	$\boxtimes$		
Left		□А	□В		□А	□В		□A	□в			
Right		□А	□в		□А	□в		□A	□в			
Тор		□А	□В		□А	□В		□A	□В			
Bottom		□A	□в		□А	□В		□А	□в			

	Contact Discharge												
Test	Test Levels										Results		
Points	±2 kV		mance erion	±4 kV		rformance ±8 Performance Criterion kV Criterion		Pass	Fail	Observation			
Front		⊠A	□в	$\boxtimes$	⊠A	□в		□А	□в	$\boxtimes$			
Back	$\boxtimes$	⊠A	□в	$\boxtimes$	⊠A	□в		□А	□в	$\boxtimes$			
Left	$\boxtimes$	⊠A	□в	$\boxtimes$	⊠A	□в		□А	□в	$\boxtimes$			
Right		□A	□в		□А	□в		□А	□в				
Тор		□A	□в		□A	□в		□A	□в				
Bottom	$\boxtimes$	⊠A	□в	$\boxtimes$	⊠A	□в		□A	□в	$\boxtimes$			

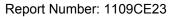
For the tested points to EUT, please refer to attached page.

(Blue arrow mark for Air Discharge and red arrow mark for Contact Discharge)

(Blue allo	Blue arrow mark for Air Discharge and red arrow mark for Contact Discharge)								
	Discharge To Horizontal Coupling Plane								
Side of		Test I	_evels				Results		
EUT	± 2 kV	± 4 kV	± 6 kV	± 8 kV	Pass	Fail	Performance Criterion	Observation	
Front	$\boxtimes$	$\boxtimes$			$\boxtimes$		⊠A □B		
Back					$\boxtimes$		⊠A □B		
Left	$\boxtimes$				$\boxtimes$		⊠A □B		
Right					$\boxtimes$		⊠A □B		

	Discharge To Vertical Coupling Plane								
Side of		Test I	_evels				Resi	ults	
EUT	± 2 kV	± 4 kV	± 6 kV	± 8 kV	Pass	Fail	Performance Criterion		Observation
Front	$\boxtimes$	$\boxtimes$			$\boxtimes$		⊠A	□в	
Back	$\boxtimes$	$\boxtimes$			$\boxtimes$		⊠A	□в	
Left	$\boxtimes$	$\boxtimes$			$\boxtimes$		⊠A	□в	
Right	$\boxtimes$	$\boxtimes$			$\boxtimes$		⊠A	□в	

NOTE: There was no change compared with initial operation during the test.





## 5.1.6. Test Photograph

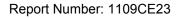
Test Mode : Mode 1

Description : Front View of ESD Test



Test Mode : Mode 1





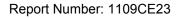
Test Mode : Mode 1

Description : Close View of ESD Test



Test Mode : Mode 1





Test Mode : Mode 1

Description : Close View of ESD Test



Test Mode : Mode 1







Test Mode : Mode 1





# 5.2. Radiated Electromagnetic Field (RS)

# 5.2.1. Test Specification

IEC 61000-4-3						
<b>Environmental Phenomena</b>	Units	Test Specification	Performance Criterion			
Enclosure Port						
Test Frequency Range	MHz	80-1000				
RF Electromagnetic Field	V/m(Un-modulated, rms)	3	Α			
Amplitude Modulated	% AM (1kHz)	80				

EUT tested in accordance with the specifications given by the standard of IEC 61000-4-3.

Step : 1%

Step time : 3 Second

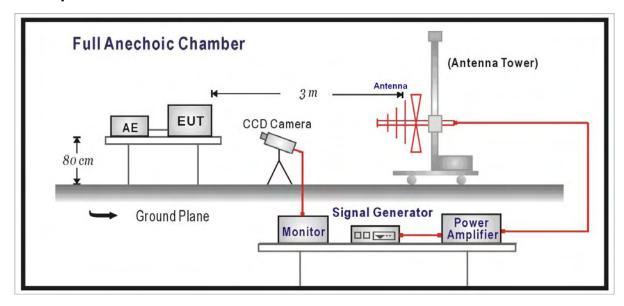
#### 5.2.2. Test Instrument

Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
SMB 100A SIGNAL GENERATOR	R&S	SMB100A	100724	02/23/2011	(1)
NRP-Z91 POWER SENSOR	R&S	NRP-Z91	100611	07/06/2011	(1)
NRP-Z91 POWER SENSOR	R&S	NRP-Z91	100612	07/07/2011	(1)
NRP POWER METER	R&S	NRP	101591	07/07/2011	(1)
Solid State Power Amplifier	BONN ELEKTRONIK	BLWA 0830-160/100/40D	87050	N.C.R.	
Signal Generator Module	R&S	SM300 Module	102209	N.C.R.	
Broad-Band Horn Antenna	Schwarzbeck Mess-Elektronik	BBHA 9120	BBHA 9120 E388	N.C.R.	
Test Site	ATL	TE07	888009	N.C.R.	

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

NOTE: N.C.R. = No Calibration Request.

#### 5.2.3. Setup



#### 5.2.4. Test Procedure

The test procedure was in accordance with IEC 61000-4-3

- a)The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b)The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80% amplitude modulated with a 1kHz sine-wave. The rate of sweep did not exceed 1.5 x 10 <sup>-3</sup> decade/s, where the frequency range is swept incrementally, the step size was 1% of preceding frequency value.
- c)The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d)The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

## 5.2.5. Test Result

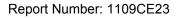
Product	Network Camera				
Test Item	Radiated Susceptibility				
Test Mode	Mode 1				
Date of Test	09/19/2011	Test Site	TE07		

Frequency (MHz)	Polarity	Azimuth	Field Strength (V/m)	Performance Criterion	Result
80 ~ 1000	Н	0	3	⊠A □B	PASS
80 ~ 1000	V	0	3	⊠A □B	PASS
80 ~ 1000	Н	90	3	⊠A □B	PASS
80 ~ 1000	V	90	3	⊠A □B	PASS
80 ~ 1000	Н	180	3	⊠A □B	PASS
80 ~ 1000	V	180	3	⊠A □B	PASS
80 ~ 1000	Н	270	3	⊠A □B	PASS
80 ~ 1000	V	270	3	⊠A □B	PASS

#### Note:

The testing performed is from lowest level up to the highest level as required by standard, but only highest level is shown on the report.

Criterion A: Operate as intended during and after the test	
Criterion B: Operate as intended after the test	
Criterion C: Loss/Error of function	
☐ Additional Information	
☐ There was no observable degradation in performance.	
☐ EUT stopped operation and could / could not be reset by operator at	V/m
at frequencyMHz.	
$\  \  \  \  \  \  \  \  \  \  \  \  \  $	





# 5.2.6. Test Photograph

Test Mode : Mode 1

Description : Front View of RS Test





## 5.3. Electrical Fast Transient/Burst (EFT)

## 5.3.1. Test Specification

	IEC 61000-4-4						
Item	Environmental Phenomena	Units	Test Specification	Performance Criterion			
I/O a	and communication ports						
Fast	Transients Common Mode	kV (Peak) Tr/Th ns Rep. Frequency kHz	+0.5 5/50 5	В			
Inpu	t DC Power Ports						
Fast Transients Common Mode		kV (Peak) Tr/Th ns Rep. Frequency kHz	+0.5 5/50 5	В			
Inpu	Input AC Power Ports						
Fast Transients Common Mode		kV (Peak) Tr/Th ns Rep. Frequency kHz	±1 5/50 5	В			

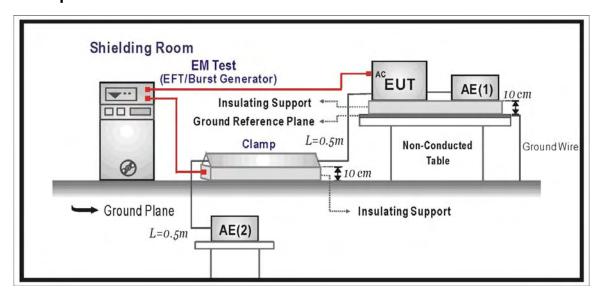
#### 5.3.2. Test Instrument

Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
EMC Immunity Tester	EMC-PARTNER AG	TRANSIENT 2000IN6	952	02/08/2011	(1)
Test Site	ATL	TE08	TE08	N.C.R.	

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

NOTE: N.C.R. = No Calibration Request.

### 5.3.3. Setup



#### 5.3.4. Test Procedure

- a) Both positive and negative polarity discharges were applied.
- b) The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 1 meter.
- c) The duration time of each test sequential was 1 minute.
- d) The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.

#### 5.3.5. Test Result

Product	Network Camera			
Test Item	Electrical Fast Transient/Burst			
Test Mode	Mode 1			
Date of Test	09/19/2011 Test Site TE08			

Test Point	Polarity	Test Level (kV)	Inject Time (Second)	Inject Method	Performance Criterion	Result
L	±	1	60	Direct	⊠A □B	PASS
N	<u>±</u>	1	60	Direct	⊠A □B	PASS
L+N	<u>±</u>	1	60	Direct	⊠A □B	PASS
LAN Port	<u>+</u>	0.5	60	Direct	⊠A □B	PASS

#### Note:

The testing performed is from lowest level up to the highest level as required by standard, but of	nly
highest level is shown on the report.	

Criterion A: Operate as intended during and after the test

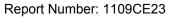
Criterion B : Operate as intended after the test

Criterion C: Loss/Error of function

	Additiona	I Inform	nation
1 1	Auditiona	1 11110111	ıauvı

☐ EUT stopped operation and could be reset by itself at\_\_\_\_\_ kV of Line.

No false alarms or other malfunctions were observed during or after the test.





# 5.3.6. Test Photograph

Test Mode : Mode 1

Description : Front View of EFT Test – AC Mains, LAN Port





## 5.4. Surge

## 5.4.1. Test Specification

	IEC61000-4-5						
Item	Environmental Phenomena	Units   Lest Specification		Performance Criterion			
Sign	al Ports and Telecommunicat	ion Ports(See 1) and 2)	)				
Surges         Tr/Th us         1.2/50 (8/20)         B           Line to Ground         kV         ± 1				В			
Input	t DC Power Ports						
Surges Line to Ground		Tr/Th us kV	1.2/50 (8/20) ± 0.5	В			
Input	Input AC Power Ports						
	es to Line to Ground	Tr/Th us kV kV	1.2/50 (8/20) ± 1 ± 2	В			

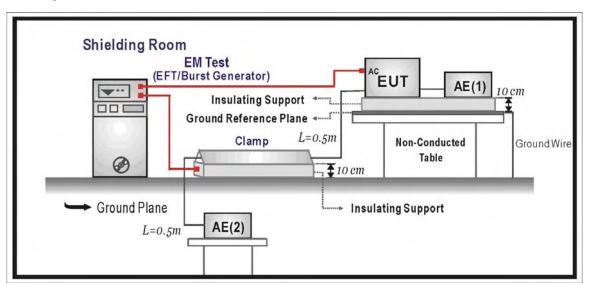
#### 5.4.2. Test Instrument

Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
EMC Immunity Tester	EMC-PARTNER AG	TRANSIENT 2000IN6	952	02/08/2011	(1)
Test Site	ATL	TE08	TE08	N.C.R.	

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

NOTE: N.C.R. = No Calibration Request.

### 5.4.3. Setup



#### 5.4.4. Test Procedure

a) For EUT power supply:

The surge is applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks was shorter than 2 meters in length.

- b) For test applied to unshielded un-symmetrically operated interconnection lines of EUT: The surge was applied to the lines via the capacitive coupling. The coupling / decoupling networks didn't influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks was shorter than 2 meters in length.
- c) For test applied to unshielded symmetrically operated interconnection / telecommunication lines of EUT:

The surge was applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor were not specified. The interconnection line between the EUT and the coupling/decoupling networks was shorter than 2 meters in length.

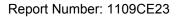
# 5.4.5. Test Result

Product	Network Camera				
Test Item	Surge				
Test Mode	Mode 1				
Date of Test	09/19/2011	Test Site	TE08		

Inject Line	Polarity	Angle	Voltage kV	Time Interval (Second)	Inject Method	Performance Criterion	Result
L+N	±	0	1kV	60	Direct	⊠A □B	Pass
L+N	±	90	1kV	60	Direct	⊠A □B	Pass
L+N	<u>±</u>	180	1kV	60	Direct	⊠A □B	Pass
L+N	±	270	1kV	60	Direct	⊠A □B	Pass

#### Note:

The testing performed is from lowest level up to the highest level as required by standard, but
only highest level is shown on the report.
Criterion A : Operate as intended during and after the test
Criterion B : Operate as intended after the test
Criterion C : Loss/Error of function
☐ Additional Information
☐ EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator atkV of
Line
No false alarms or other malfunctions were observed during or after the test.





# 5.4.6. Test Photograph

Test Mode : Mode 1

Description : Front View of Surge Test – AC Mains



# 5.5. Conducted Susceptibility (CS)

# 5.5.1. Test Specification

IEC 61000-4-6						
<b>Environmental Phenomena</b>	Units	Test Specification	Performance Criterion			
Signal Ports and Telecommunication Ports						
	MHz	0.15-80				
Radio-Frequency Continuous Conducted	V (rms, Un-modulated)	3	Α			
	% AM (1kHz)	80				
Input DC Power Ports						
	MHz	0.15-80				
Radio-Frequency Continuous Conducted	V (rms, Un-modulated)	3	Α			
Continuodo Conductod	% AM (1kHz)	80				
Input AC Power Ports						
5 5	MHz	0.15-80				
Radio-Frequency Continuous Conducted	V (rms, Un-modulated)	3	Α			
Continuodo Conductod	% AM (1kHz)	80				

EUT tested in accordance with the specifications given by the standard of IEC 61000-4-6.

Step : 1%

Step time : 3 Second

### 5.5.2. Test Instrument

Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
Signal Line Coupling Decoupling Network	FCC	FCC-801T2-RJ11	8017	07/07/2011	(1)
Signal Line Coupling Decoupling Network	FCC	FCC-801T4-RJ45	8018	07/07/2011	(1)
Signal Line Coupling Decoupling Network	FCC	FCC-801-M2/M3-1 6A8030	8030	07/07/2011	(1)
EM Injection Clamp	FCC	F-203I-23MM	8576	07/07/2011	(1)
Amplifiers	ar	75A250A	328729	07/07/2011	(1)
NRP-Z91 POWER SENSOR	R&S	NRP-Z91	100613	07/07/2011	(1)
De-coupling Network	FCC	F-203I-23MM- DCN	8234	N.C.R.	
Test Site	ATL	TE08	TE08	N.C.R.	

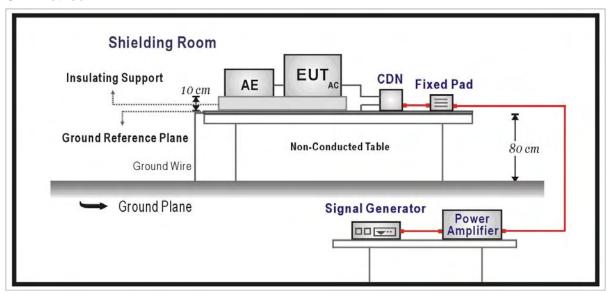
Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

NOTE: N.C.R. = No Calibration Request.

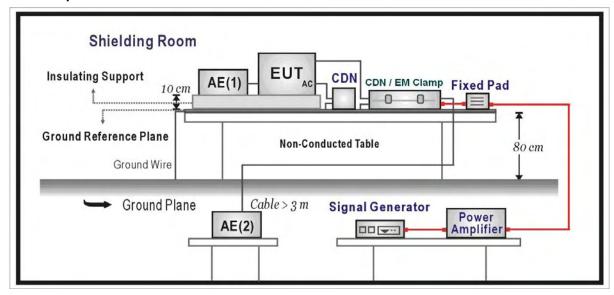


### 5.5.3. Setup

#### **CDN Method**



#### **EM Clamp Method**



#### 5.5.4. Test Procedure

The EUT shall be tested within its intended operating and climatic conditions.

The test shell performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.

The frequency range was swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal was modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. The sweep rate was  $1.5 \times 10^{-3}$  decades/s. Where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value from 150 kHz to 80 MHz.

The dwell time at each frequency was less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies such as clock frequency and harmonics or frequencies of dominant interest, was analyzed separately.

Attempts was made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.

#### 5.5.5. Test Result

Product	Network Camera			
Test Item	Conducted Susceptibility			
Test Mode	Mode 1			
Date of Test	09/14/2011	Test Site	TE08	

Frequency Band (MHz)	Field Strength (Vrms)	Inject Port	Inject Method	Performance Criterion	Result
0.15 ~ 80	3	AC Mains	CDN-M2	⊠A □B	PASS
0.15 ~ 80	3	LAN Port	Clamp	⊠A □B	PASS

#### Note:

The testing performed is from lowest level up to the highest level as required by standard, but only highest level is shown on the report.

Criterion A: Operate as intended during and after the test

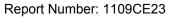
Criterion B : Operate as intended after the test

Criterion C : Loss/Error of function

☐ Additional Information

EUT stopped	operation	and <u>could</u> /	could not be	reset by	operator at	 dBuV (	(V) at
frequency	MHz.						

No false alarms or other malfunctions were observed during or after the test.
 The acceptance criteria were met, and the EUT passed the test.

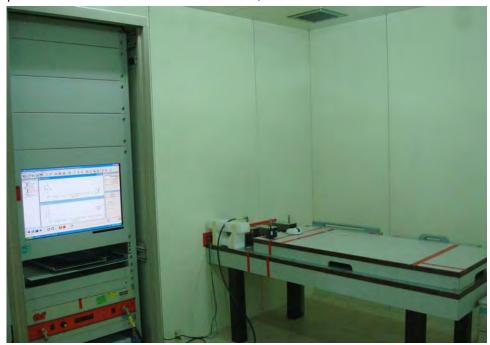


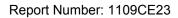


# 5.5.6. Test Photograph

Test Mode : Mode 1

Description : Front View of CS Test – AC Mains, LAN Port







## 5.6. Power Frequency Magnetic Field (PMF)

## 5.6.1. Test Specification

	IEC 61000-4-8						
Item	Item         Environmental Phenomena         Units         Test Specification         Performance Criterion						
Enclosu	Enclosure Port						
	Power-Frequency Magnetic Field	Hz A/m (r.m.s.)	50 1	А			

EUT tested in accordance with the specifications given by the standard of IEC 61000-4-8.

Orientation : X, Y, Z
Test time : 180 Second

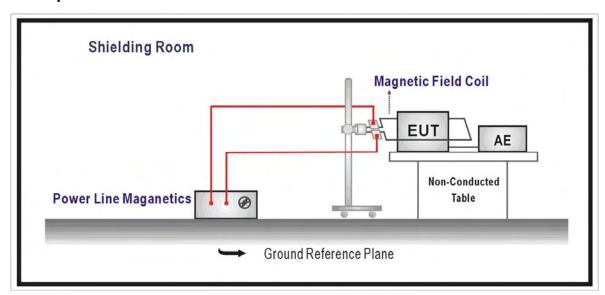
#### 5.6.2. Test Instrument

Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
EMC Immunity Tester	EMC-PARTNER AG	TRANSIENT 2000IN6	952	02/08/2011	(1)
Magentic Field Antenna	EMC-PARTNER AG	MF1000-1	155	02/07/2011	(1)
Test Site	ATL	TE08	TE08	N.C.R.	

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

NOTE: N.C.R. = No Calibration Request.

### 5.6.3. Setup



#### 5.6.4. Test Procedure

- a). The equipment was configured and connected to satisfy its functional requirements. It shall be placed on the GRP with the interposition of a 0.1m-thick insulating support.
- b). The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.
- c). The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- d). The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

#### 5.6.5. Test Result

Product	Network Camera			
Test Item	Power Frequency Magnetic Field			
Test Mode	Mode 1			
Date of Test	09/19/2011	Test Site	TE08	

Polarization	Frequency (Hz)	Magnetic Strength (A/m)	Performance Criterion	Result
X Orientation	50	1	⊠A □B	PASS
Y Orientation	50	1	⊠A □B	PASS
Z Orientation	50	1	⊠A □B	PASS

Note:

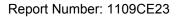
Criterion A : Operate as intended during and after the test

Criterion B : Operate as intended after the test

Criterion C: Loss/Error of function

☐ Additional Information	
☐ EUT stopped operation and could / could not be reset by operator at	dBuV (V) at frequency
MHz.	

No false alarms or other malfunctions were observed during or after the test. The acceptance criteria were met, and the EUT passed the test.





# 5.6.6. Test Photograph

Test Mode : Mode 1

Description : Front View of PMF Test





# 5.7. Voltage Dips and Interruption

# 5.7.1. Test Specification

IEC 61000-4-11					
Environmental Phenomena	Units	Test Specification	Performance Criterion		
Input AC Power Ports					
Voltogo Dina	0	% Reduction	В		
	0.5	Period	Ь		
Voltage Dips	70	% Reduction	С		
	25	Period			
Voltage Interruptions	0	% Reduction	С		
	voltage Interruptions 250				

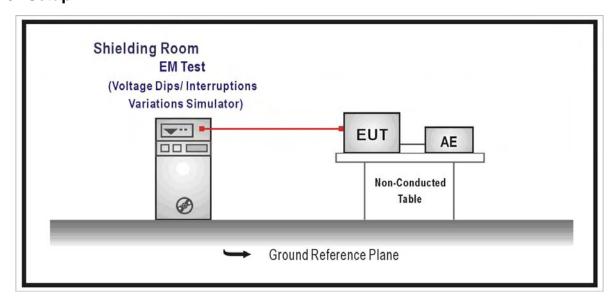
#### 5.7.2. Test Instrument

Equipment	Manufacturer	Model Number	Serial Number	Cal. Date	Remark
EMC Immunity Tester	EMC-PARTNER AG	TRANSIENT 2000IN6	952	02/08/2011	(1)
Test Site	ATL	TE08	TE08	N.C.R.	

Remark: (1) Calibration period 1 year. (2) Calibration period 2 years.

NOTE: N.C.R. = No Calibration Request.

### 5.7.3. Setup



#### 5.7.4. Test Procedure

The EUT and its load are placed on a table which is 0.8 meter above a metal ground plane measured 1m\*1m min. And 0.65mm thick min. And projected beyond the EUT by at least 0.1m on all sides. The power cord shall be used the shortest power cord as specified by the manufacturer.

For Voltage Dips/ Interruptions test:

The selection of test voltage is based on the rated power range. If the operation range is large than 20% of lower power range, both end of specified voltage shall be tested. Otherwise, the typical voltage specification is selected as test voltage.

The EUT is connected to the power mains through a coupling device that directly couples to the Voltage Dips and Interruption Generator.

The EUT shall be tested for 30% voltage dip of supplied voltage and duration 25 Periods,

for 95% voltage dip of supplied voltage and duration 0.5 Periods with a sequence of three voltage dips with intervals of 10 seconds, and for 95% voltage interruption of supplied voltage and duration 250 Periods with a sequence of three voltage interruptions with intervals of 10 seconds.

Voltage phase shifting are shall occur at  $0^{0}$ ,  $45^{0}$ ,  $90^{0}$ ,  $135^{0}$ ,  $180^{0}$ ,  $225^{0}$ ,  $270^{0}$ ,  $315^{0}$  of the voltage.

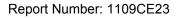
## 5.7.5. Test Result

Product	Network Camera		
Test Item	Voltage Dips and Interruption Measurement		
Test Mode	Mode 1		
Date of Test	09/19/2011	Test Site	TE08

Voltage Reduction (%)	Angle	Test Duration (ms)	Performance Criterion	Test Result	Observation
>95(0V)	0	10	⊠A □B □C	Pass	Note 1
>95(0V)	45	10	⊠A □B □C	Pass	Note 1
>95(0V)	90	10	⊠A ∏B ∏C	Pass	Note 1
>95(0V)	135	10	⊠A ∏B ∏C	Pass	Note 1
>95(0V)	180	10	⊠A ∏B ∏C	Pass	Note 1
>95(0V)	225	10	⊠A □B □C	Pass	Note 1
>95(0V)	270	10	⊠A ∏B ∏C	Pass	Note 1
>95(0V)	315	10	⊠A ∏B ∏C	Pass	Note 1
30(161V)	0	500	⊠A ⊟B ⊟C	Pass	Note 1
30(161V)	45	500	⊠A □B □C	Pass	Note 1
30(161V)	90	500	⊠A □B □C	Pass	Note 1
30(161V)	135	500	⊠A ∏B ∏C	Pass	Note 1
30(161V)	180	500	⊠A ∏B ∏C	Pass	Note 1
30(161V)	225	500	⊠A ∏B ∏C	Pass	Note 1
30(161V)	270	500	⊠A □B □C	Pass	Note 1
30(161V)	315	500	⊠A ∏B ∏C	Pass	Note 1
>95(0V)	0	5000	□A □B ⊠C	Pass	Note 2
>95(0V)	45	5000	□A □B ⊠C	Pass	Note 2
>95(0V)	90	5000	□A □B ⊠C	Pass	Note 2
>95(0V)	135	5000	□A □B ⊠C	Pass	Note 2
>95(0V)	180	5000	□A □B ⊠C	Pass	Note 2
>95(0V)	225	5000	□A □B ⊠C	Pass	Note 2
>95(0V)	270	5000	□A □B ⊠C	Pass	Note 2
>95(0V)	315	5000	□A □B ⊠C	Pass	Note 2

Note: 1.

The acceptance criteria were met, and the EUT passed the test.
Criterion A : Operate as intended during and after the test
Criterion B : Operate as intended after the test
Criterion C : Loss/Error of function
☐ Additional Information
☐ EUT stopped operation and <u>could / could not</u> be reset by operator atdBuV(V) at
frequencyMHz.
No false alarms or other malfunctions were observed during or after the test.
2. The power is temporary off and can be reset by the operator.





# 5.7.6. Test Photograph

Test Mode : Mode 1

Description : Front View of Dips Test





# 6 EUT Photograph

(1) EUT Photo



## (2) EUT Photo





### (3) EUT Photo



#### (4) EUT Photo



# (5) EUT Photo

